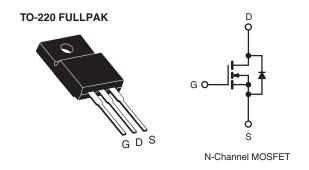


Vishay Siliconix

Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	60			
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = 5.0 V	0.20		
Q _g (Max.) (nC)	8.4			
Q _{gs} (nC)	3.5			
Q _{gd} (nC)	6.0			
Configuration	Single			



FEATURES

- · Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz



- Sink to Lead Creepage Distance = 4.8 mm
- · Logic-Level Gate Drive
- R_{DS(on)} Specified at V_{GS} = 4 V and 5 V
- Fast Switching
- · Ease of Paralleling
- Compliant to RoHS Directive 2002/95/EC

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The molding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION	
Package	TO-220 FULLPAK
Lead (Pb)-free	IRLIZ14GPbF
	SiHLIZ14G-E3
SnPb	IRLIZ14G
	SiHLIZ14G

ABSOLUTE MAXIMUM RATINGS T _C = 25 °C, unless otherwise noted						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	60	V	
Gate-Source Voltage			V_{GS}	± 10	V	
Continuous Drain Current	V _{GS} at 5.0 V	T _C = 25 °C	- I _D	8.0		
		$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$		5.7	Α	
Pulsed Drain Current ^a			I _{DM}	32		
Linear Derating Factor				0.18	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	39.5	mJ	
Maximum Power Dissipation $T_C = 25 ^{\circ}C$			P_{D}	27	W	
Peak Diode Recovery dV/dt ^c			dV/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stq}	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d]	
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N · m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD}=25$ V, starting $T_J=25$ °C, L=0.79 mH, $R_G=25$ Ω , $I_{AS}=10$ A (see fig. 12). c. $I_{SD}\leq 10$ A, $dI/dt\leq 90$ A/ μ s, $V_{DD}\leq V_{DS}$, $T_J\leq 175$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRLIZ14G, SiHLIZ14G

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	65	°C/W	
Maximum Junction-to-Case (Drain)	R_{thJC}	-	5.5	C/VV	

SPECIFICATIONS T _J = 25 °C, PARAMETER	SYMBOL		T CONDITIONS	MIN.	TYP.	MAX.	UNIT	
	SYMBOL	TEST CONDITIONS		IVIIN.	IYP.	WAX.	UNII	
Static	.,	1 1	01/ 1 050 4	60	I	I		
Drain-Source Breakdown Voltage	V _{DS}	.	V _{GS} = 0 V, I _D = 250 μA			-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$		ee to 25 °C, I _D = 1 mA	-	0.070	-	V/°C	
Gate-Source Threshold Voltage	V _{GS(th)}		V_{GS} , $I_{D} = 250 \mu\text{A}$	1.0	-	2.0	V	
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 10 V	-	-	± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}$		-	-	25	μΑ	
Zoro date Voltage Brain Garrent	1088	$V_{DS} = 48 V_{s}$	V _{DS} = 48 V, V _{GS} = 0 V, T _J = 150 °C		-	250		
Drain Source On State Resistance	-	V _{GS} = 5.0 V	$I_D = 4.8 A^b$	-	-	0.20		
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 4.0 V	$I_D = 4.0 \text{ A}^b$	-	-	0.28	Ω	
Forward Transconductance	9 _{fs}	V _{DS} =	25 V, I _D = 4.8 A ^b	3.6	-	-	S	
Dynamic								
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ $f = 1.0 \text{ MHz}, \text{ see fig. 5}$		-	400	-		
Output Capacitance	C _{oss}			-	170	-	- pF	
Reverse Transfer Capacitance	C _{rss}			-	42	-		
Drain to Sink Capacitance	С			-	12	-		
Total Gate Charge	Qg		I _D = 10 A, V _{DS} = 48 V, see fig. 6 and 13 ^b	-	-	8.4	nC	
Gate-Source Charge	Q _{gs}	V _{GS} = 5.0 V		-	-	3.5		
Gate-Drain Charge	Q _{gd}			-	-	6.0		
Turn-On Delay Time	t _{d(on)}			-	9.3	-		
Rise Time	t _r		$V_{DD} = 30 \text{ V}, I_{D} = 10 \text{ A},$		110	-	- ns	
Turn-Off Delay Time	t _{d(off)}	$R_G = 12 \Omega$, $R_D = 2.8 \Omega$, see fig. 10^b		-	17	-		
Fall Time	t _f			-	26	-		
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-		
Internal Source Inductance	L _S			-	7.5	-	nH	
Drain-Source Body Diode Characteristic	s	1		ļ	L	L		
Continuous Source-Drain Diode Current	Is	MOSFET symbol showing the integral reverse p - n junction diode		-	-	8.0		
Pulsed Diode Forward Current ^a	I _{SM}			-	-	32	A	
Body Diode Voltage	V _{SD}	T _J = 25 °C, I _S = 8.0 A, V _{GS} = 0 V ^b		-	-	1.6	٧	
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 \text{ °C}, I_F = 10 \text{ A, dI/dt} = 100 \text{ A/}\mu\text{s}^b$		-	65	130	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.33	0.65	μС	
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)					LD)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width $\leq 300~\mu s;$ duty cycle $\leq 2~\%.$



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

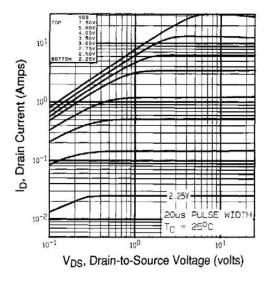


Fig. 1 - Typical Output Characteristics, $T_C = 25$ °C

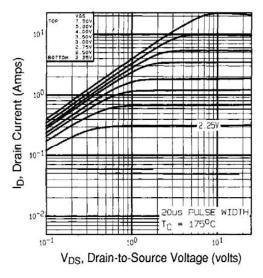


Fig. 2 - Typical Output Characteristics, T_C= 175 °C

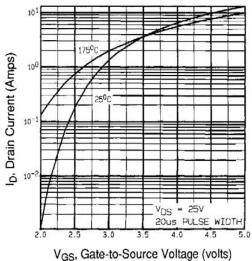
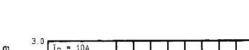


Fig. 3 - Typical Transfer Characteristics



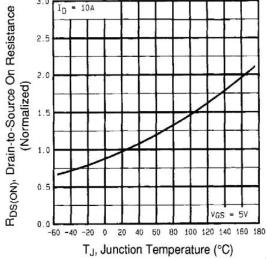


Fig. 4 - Normalized On-Resistance vs. Temperature

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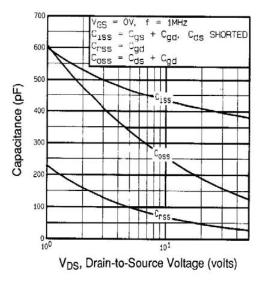


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

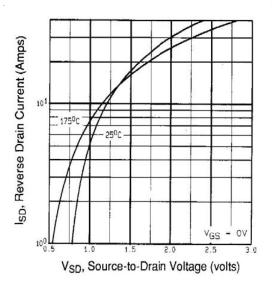


Fig. 7 - Typical Source-Drain Diode Forward Voltage

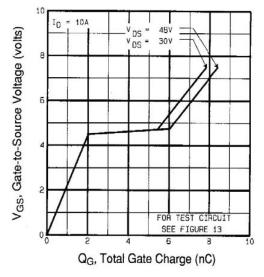


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

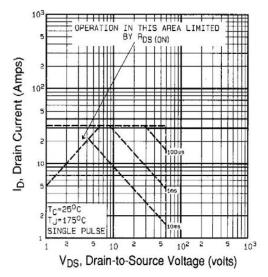


Fig. 8 - Maximum Safe Operating Area



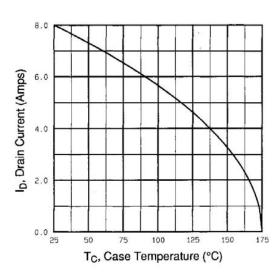


Fig. 9 - Maximum Drain Current vs. Case Temperature

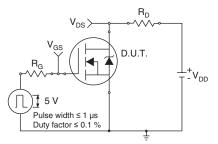


Fig. 10a - Switching Time Test Circuit

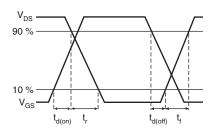
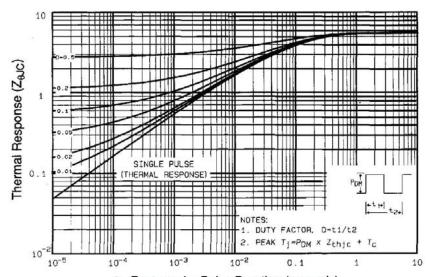


Fig. 10b - Switching Time Waveforms



t₁, Rectangular Pulse Duration (seconds)

Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

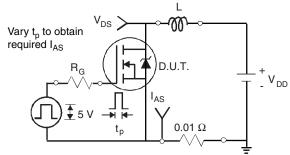


Fig. 12a - Unclamped Inductive Test Circuit

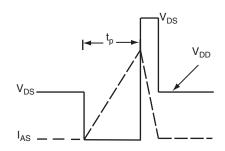
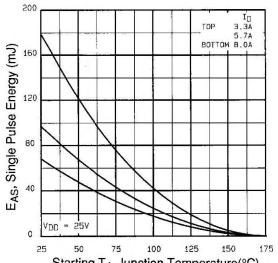


Fig. 12b - Unclamped Inductive Waveforms

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 $Starting \ T_J, \ Junction \ Temperature (^{\circ}C)$ Fig. 12c - Maximum Avalanche Energy vs. Drain Current

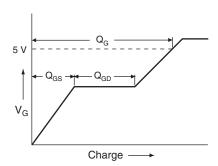


Fig. 13a - Basic Gate Charge Waveform

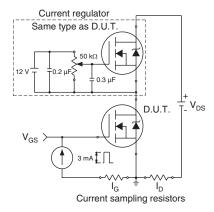
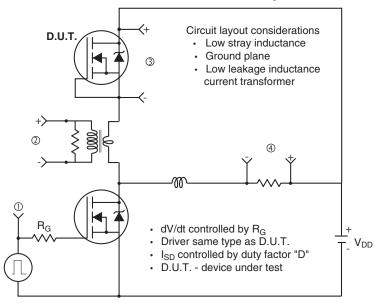
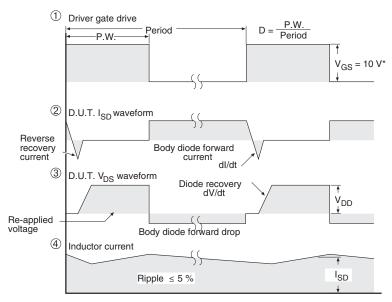


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit





* V_{GS} = 5 V for logic level devices and 3 V drive devices

Fig. 14 - For N-Channel

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